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# STS5DNF20V

# N-channel 20 V, 0.030 Ω typ, 5 A STripFET™ II Power MOSFET in a SO-8 package

Datasheet - production data

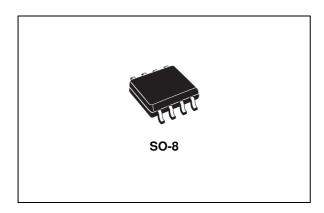
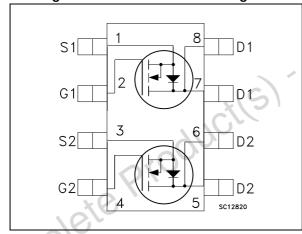


Figure 1. Internal schematic diagram



### **Features**

Order code	V <sub>DSS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STS5DNF20V	20 V	0.040 Ω @ 4.5 V	5 A
0100DN120V	20 V	0.045 Ω @ 2.7 V	JA

- Ultra low threshold gate drive (2.7 V)
- Standard outline for easy automated surface mount assembly

## **Applications**

· Switching application

## Description

This Power MOSFET has been developed using STMicroelectronics' unique STripFET process, which is specifically designed to minimize input capacitance and gate charge. This renders the device suitable for use as primary switch in advanced high-efficiency isolated DC-DC converters for telecom and computer applications, and applications with low gate charge driving requirements.

Table 1. Device summary

Order code	Marking	Package	Packaging
STS5DNF20V	5DF20V	SO-8	Tape and reel

Contents STS5DNF20V

## **Contents**

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0050	Electrical characteristics



STS5DNF20V Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)	20	V
$V_{GS}$	Gate-source voltage	±12	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	5	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	3	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	20	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C (dual operation)	1.6	W
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C (single operation)	2	W
T <sub>J</sub>	Max. operating junction temperature	-55 to 150	°C
T <sub>stg</sub>	Storage temperature	355 to 150	)

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

	Symbol	Parameter	Value	Unit
	D	Thermal resistance junction-ambient single operation	62.5	°C/W
	R <sub>thj-a</sub>	Thermal resistance junction-ambient dual operation	78	°C/W
Obsole	ReP	rodulos		

**Electrical characteristics** STS5DNF20V

#### 2 **Electrical characteristics**

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown voltage	$I_D = 250 \mu\text{A},  V_{GS} = 0$	20			٧
1	Zero gate voltage	V <sub>DS</sub> = 20			1	μΑ
I <sub>DSS</sub>	Drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 20 V, T <sub>C</sub> =125 °C			10	μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 12 V		·	±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	10,0		Ω
Brack	Static drain-source	$V_{GS} = 4.5 \text{ V}, I_D = 2.5 \text{ A}$	v O	0.030	0.040	Ω
R <sub>DS(on)</sub>	on- resistance	$V_{GS} = 2.7 \text{ V}, I_D = 2.5 \text{ A}$		0.037	0.045	Ω

### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance	V 05.V ( 4.MI)	-	460		pF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	200		pF
C <sub>rss</sub>	Reverse transfer capacitance	143	-	50		pF
Qg	Total gate charge	V <sub>DD</sub> = 16 V, I <sub>D</sub> = 5 A,	-	8.5	11.5	nC
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 4.5 V	-	1.8		nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 13)	-	2.4		nC

### Table 6. Switching times

	Q <sub>gd</sub> Gate-drain charge		(see <i>Figure 13</i> )	-	2.4		nC
. ~	19	Table	6. Switching times				
0/6	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
-WS	t <sub>d(on)</sub>	Turn-on delay time		-	7	-	ns
$O_{\mathcal{O}}$	t <sub>r</sub>	Rise time	$V_{DD}$ =10 V, $I_{D}$ =2.5A, $R_{G}$ =4.7 $\Omega$ , $V_{GS}$ = 4.5V	-	33	-	ns
	t <sub>d(off)</sub>	Turn-off delay time	(see <i>Figure 12</i> )	-	27	-	ns
	t <sub>f</sub>	Fall Time		-	10	-	ns



Table 7. Source drain diode

Symbol	Dawa	Took oon distance	B.#:	T	NA	11		
1 1	Parameter	Test conditions	Min.	Тур.	Max	Unit		
I <sub>SD</sub>	Source-drain current		-		5	Α		
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		20	Α		
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 5 A, V_{GS} = 0$	-		1.2	V		
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 5 \text{ A}, V_{DD} = 10 \text{ V},$	-	26		ns		
$Q_{rr}$	Reverse recovery charge	di/dt = 100 A/μs, T <sub>i</sub> = 150 °C	-	13		nC		
$I_{RRM}$	Reverse recovery current	(see Figure 14)	-	1		Α		
. Pulse wid	Ith limited by safe operating area.	•						
$T_j = 150 \text{ °C}$								

**Electrical characteristics** STS5DNF20V

#### **Electrical characteristics (curves)** 2.1

Figure 2. Safe operating area

lo(A) 10<sup>1</sup>

Figure 3. Thermal impedance

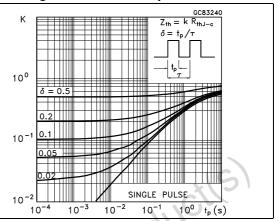


Figure 4. Output characteristics

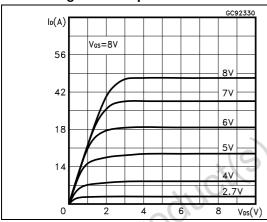


Figure 5. Transfer characteristics

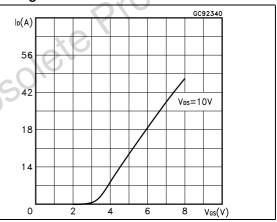
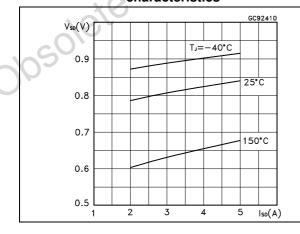


Figure 6. Source-drain diode forward characteristics

Figure 7. Static drain-source on resistance



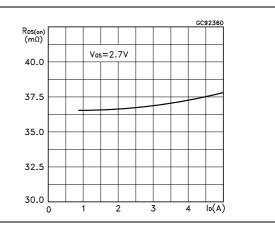


Figure 8. Gate charge vs gate-source voltage

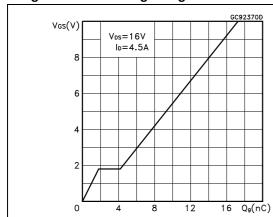


Figure 9. Capacitance variations

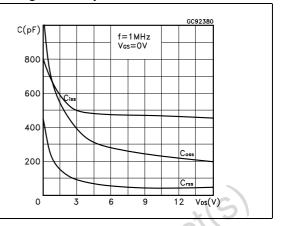
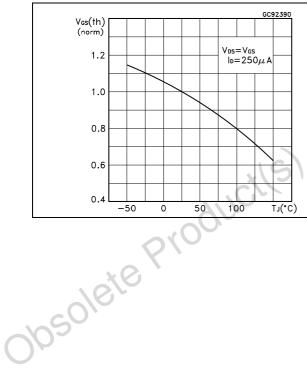
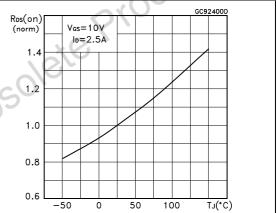


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature





Test circuit STS5DNF20V

## 3 Test circuit

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

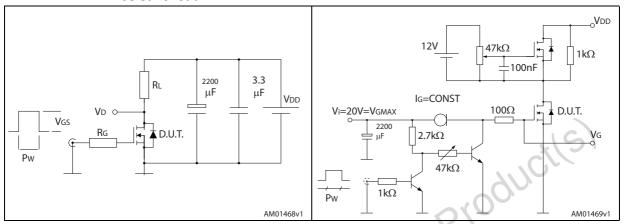


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped Inductive load test circuit

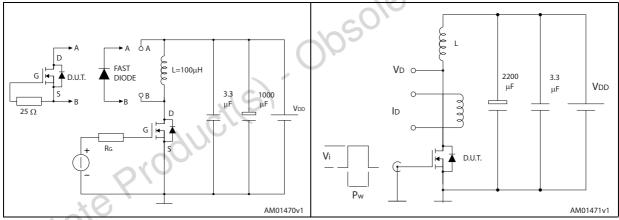
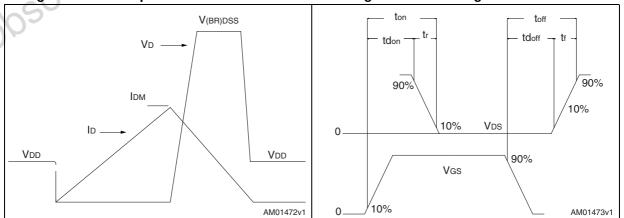


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



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## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



4 □ ccc C SEATING PLANE С SECTION B-B BASE METAL -Obsolete Product(s). Ob 0016023\_G\_FU

Figure 18. SO-8 drawing

Table 8. SO-8 mechanical data

			mm	
	Dim.	Min.	Тур.	Max.
	А			1.75
	A1	0.10		0.25
	A2	1.25		
	b	0.31		0.51
	b1	0.28		0.48
	С	0.10		0.25
	c1	0.10		0.23
	D	4.80	4.90	5.00
	E	5.80	6.00	6.20
	E1	3.80	3.90	4.00
	е		1.27	
	h	0.25	16/	0.50
	L	0.40	°CO,	1.27
	L1		1.04	
	L2		0.25	
	k	0°		8°
	CCC	A CALLON		0.10
opsolei	ePro	)QiO.		

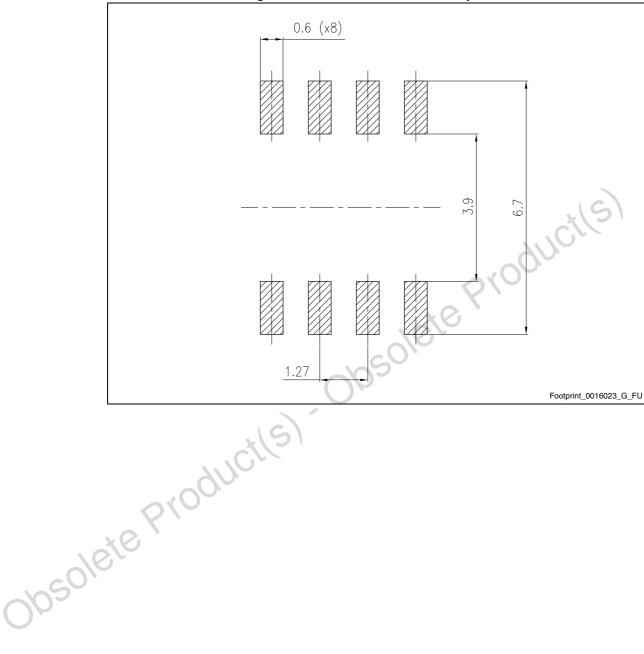


Figure 19. SO-8 recommended footprint<sup>(a)</sup>

a. All dimensions are in millimeters.

STS5DNF20V Revision history

# 5 Revision history

Table 9. Revision history

	Date	Revision	Changes
	21-Jun-2004	4	Complete document
	13-Nov-2006	5	The document has been reformatted
	02-May-2011	6	Table 1: Device summary has been corrected
	06-Mar-2014	7	Modified: Marking in Table 1 Updated: Section 4: Package mechanical data, Figure 12: Switching times test circuit for resistive load, Figure 13: Gate charge test circuit, Figure 14: Test circuit for inductive load switching and diode recovery times and Figure 15: Unclamped Inductive load test circuit. Minor text changes.
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